# EVERLIGHT

# DATASHEET

## 8 PIN SOP HIGH SPEED 10MBit/s LOGIC GATE PHOTOCOUPLER EL06XX Series



#### **Features**

- Compliance Halogen Free .
- (Br <900 ppm ,Cl <900 ppm , Br+Cl < 1500 ppm)
- High speed 10Mbit/s
- 10kV/µs minimum commone mode transient immunity at VCM= 1KV (EL0611)
- Guaranteed performance from -40 to 85°C
- Wide operating temperature range of -40°C to 100°C
- Logic gate output
- High isolation voltage between input and output (Viso=3750 V rms)
- Compliance with EU REACH
- Pb free and RoHS compliant.
- UL and cUL approved(No. E214129)
- VDE approved (No. 40028116)
- SEMKO approved
- NEMKO approved
- DEMKO approved
- FIMKO approved

#### Description

The EL0600, EL0601 and EL0611 devices each consists of an infrared emitting diode optically coupled to a high speed integrated photo detector logic gate with a strobable output. The devices are packaged in an 8-pin small outline package which conforms to the standard SO8 footprint.

#### Applications

- Ground loop elimination
- LSTTL to TTL, LSTTL or 5 volt CMOS
- Line receiver, data transmission
- Data multiplexing
- Switching power supplies
- Pulse transformer replacement
- Computer peripheral interface
- High speed logic ground isolation

#### Truth Table (Positive Logic)

•	• /	
Input	Enable	Output
Н	Н	L
L	Н	Н
Н	L	Н
L	L	Н
Н	NC	L
L	NC	Н



A 0.1 $\mu F$  bypass capacitor must be connected between pins 8 and 5  $^{\star3}$ 

#### Pin Configuration

- 1, No Connection
- 2, Anode
- 3, Cathode
- 4. No Connection
- 5, Gnd
- 6, Vout
- 7, V<sub>E</sub>
- 8, V<sub>CC</sub>

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#### Absolute Maximum Ratings (Ta=25°C)

Parameter		Symbol	Rating	Unit
	Forward current	I <sub>F</sub>	20	mA
Input	Enable input voltage Not exceed $V_{CC}$ by more than 500mV	V <sub>E</sub>	5.5	V
mput	Reverse voltage	V <sub>R</sub>	5	V
	Power dissipation	PD	40	mW
	Power dissipation	Pc	85	mW
0.1.1	Enable input current	Ι <sub>Ε</sub>	5	mA
Output	Output current	Ι <sub>Ο</sub>	50	mA
	Output voltage	Vo	7.0	V
Output Power Dissipation		Po	100	mW
Isolation voltage <sup>*1</sup>		V <sub>ISO</sub>	3750	V rms
Operating temperature		T <sub>OPR</sub>	-40 ~ +100	°C
Storage t	Storage temperature		-55 ~ +125	°C
Soldering	g temperature *2	T <sub>SOL</sub>	260	°C

#### Notes:

\*1 AC for 1 minute, R.H.= 40 ~ 60% R.H. In this test, pins 1, 2, 3 & 4 are shorted together, and pins 5, 6, 7 & 8 are shorted together.

\*2 For 10 seconds.

#### Electrical Characteristics (Ta=-40 to 85°C unless specified otherwise)

#### Input

Parameter	Symbol	Min.	Тур.	Max.	Unit	Condition
Forward voltage	V <sub>F</sub>	-	1.4	1.8	V	$I_F = 10 \text{mA}$
Reverse voltage	V <sub>R</sub>	5.0	-	-	V	I <sub>R</sub> = 10μΑ
Temperature coefficient of forward voltage	$\Delta V_{F} / \Delta T_{A}$	-	-1.8	-	mV/°C	I <sub>F</sub> =10mA
Input capacitance	C <sub>IN</sub>	-	60	-	pF	V <sub>F</sub> =0, f=1MHz

#### Output

Parameter	Symbol	Min	Тур.	Max.	Unit	Condition
High level supply current	I <sub>CCH</sub>	-	-	10	mA	I <sub>F</sub> =10mA, V <sub>E</sub> =0.5V, V <sub>CC</sub> =5.5V
Low level supply current	I <sub>CCL</sub>	-	-	13	mA	$I_F=0mA$ , $V_E=0.5V$ , $V_{CC}=5.5V$
High level enable current	I <sub>EH</sub>	-	-	-1.6	mA	V <sub>E</sub> =2.0V, V <sub>CC</sub> =5.5V
Low level enable current	I <sub>EL</sub>	-	-	-1.6	mA	$V_{E}$ =0.5V, $V_{CC}$ =5.5V
High level enable voltage	$V_{EH}$	2.0	-	-	V	I <sub>F</sub> =10mA, V <sub>CC</sub> =5.5V
Low level enable voltage <sup>*4</sup>	$V_{EL}$	-	-	0.8	V	I <sub>F</sub> =10mA, V <sub>CC</sub> =5.5V

### Transfer Characteristics (Ta=-40 to 85°C unless specified otherwise)

Parameter	Symbol	Min	Тур.	Max.	Unit	Condition
HIGH Level Output Current	I <sub>OH</sub>	-	-	100	uA	V <sub>CC</sub> =5.5V, V <sub>O</sub> =5.5V, I <sub>F</sub> =250µA, V <sub>E</sub> =2.0V
LOW Level Output Current	V <sub>OL</sub>	-	-	0.6	V	$V_{CC} = 5.5V$ , I <sub>F</sub> =5mA, $V_{E}$ =2.0V,I <sub>CL</sub> =13mA
Input Threshold Current	I <sub>FT</sub>	-	-	5	mA	V <sub>CC</sub> = 5.5V, V <sub>O</sub> =0.6V, V <sub>E</sub> =2.0V,I <sub>O</sub> L=13mA

#### Switching Characteristics (T<sub>a</sub>=-40 to 85°C, V<sub>CC</sub>=5V, I<sub>F</sub>=7.5mA unless specified otherwise)

Parameter	Symbol	Min	Тур.	Max.	Unit	Condition
Propagation delay time to output High level* <sup>5</sup> (Fig.12)	T <sub>PHL</sub>	-	35	75	ns	C <sub>L</sub> = 15pF, R <sub>L</sub> =350Ω, TA=25°C
Propagation delay time to output Low level* <sup>6</sup> (Fig.12)	T <sub>PLH</sub>	-	45	75	ns	C <sub>L</sub> = 15pF, R <sub>L</sub> =350Ω, TA=25°C
Pulse width distortion	Tphl – Tplh	-	10	35	ns	$C_{L} = 15 pF, R_{L} = 350 \Omega$
Output rise time* <sup>7</sup> (Fig.12)	tr	-	30	40	ns	$C_{L} = 15 pF, R_{L} = 350 \Omega$
Output fall time* <sup>8</sup> (Fig.12)	tf	-	10	20	ns	$C_L = 15 pF, R_L = 350 \Omega$

### Switching Characteristics ( $T_a$ =-40 to 85°C, $V_{CC}$ =5V, $I_F$ =7.5mA unless specified otherwise)

Param	neter	Symbol	Min	Тур.	Max.	Unit	Condition
Enable Prop Delay Time High Level* (Fig.13)	to Output	t <sub>ELH</sub>	-	30	40	ns	$I_F = 7.5 \text{mA}$ , $V_{EH} = 3.5 \text{V}$ , $C_L = 15 \text{pF}$ , $R_L = 350 \Omega$
Enable Prop Delay Time Low Level <sup>*1</sup> (Fig.13)	to Output	t <sub>EHL</sub>	-	20	30	ns	$I_F$ = 7.5mA , V <sub>EH</sub> =3.5V, C <sub>L</sub> = 15pF, R <sub>L</sub> =350Ω
	EL0600		-	-	-		I <sub>F</sub> = 7.5mA , V <sub>OH</sub> =2.0V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =10Vp-p (Fig.14)
Common Mode Transient	EL0601		5,000	-	-		I <sub>F</sub> = 7.5mA , V <sub>OH</sub> =2.0V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =50Vp-p (Fig.14)
Immunity at Logic High <sup>*11</sup>	EL0611	CM <sub>H</sub>	10,000	-	-	V/µS	I <sub>F</sub> = 7.5mA , V <sub>OH</sub> =2.0V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =400Vp-p (Fig.14)
	EL0611		15,000	-	-		I <sub>F</sub> = 7.5mA , V <sub>OH</sub> =2.0V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =400Vp-p (Fig.15)
	EL0600		-	-	-		I <sub>F</sub> = 0mA , V <sub>OL</sub> =0.8V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =10Vp-p (Fig.14)
Common Mode Transient	EL0601	CM	5,000			V/µS	I <sub>F</sub> = 0mA , V <sub>OL</sub> =0.8V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =50Vp-p (Fig.14)
Immunity at Logic Low <sup>*12</sup>	EL0611	CML	10,000	-	-	ν/μο	I <sub>F</sub> = 0mA , V <sub>OL</sub> =0.8V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =400Vp-p (Fig.14)
	EL0611		15,000	-	-		I <sub>F</sub> = 7.5mA , V <sub>OL</sub> =0.8V, R <sub>L</sub> =350Ω, TA=25°C V <sub>CM</sub> =400Vp-p (Fig.15)

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#### **Typical Electro-Optical Characteristics Curves**

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#### Figure 8. Propagation Delay vs. Temperature Figure 7. Propagation Delay vs. Forward Current 120 120 V\_\_\_\_=5V 100 100 $R_{L}=4k\Omega(T_{PLH})$ $R_{L} = 4k\Omega(T_{PL})$ Propagation Delay, T<sub>p</sub> (ns) Propagation Delay, T<sub>p</sub> (ns) 80 80 60 60 $R_i = 1k\Omega(T_{PHL})$ $R_{L} = 1 k \Omega(T_{PHL})$ R =350Ω(T R\_=4kΩ R, =350Ω(T<sub>PLH</sub>) 40 40 (T<sub>PHL</sub>) R<sub>L</sub>=1kΩ / R<sub>L</sub>=350Ω =4kΩ R =4kΩ R =1kΩ (T<sub>PHI</sub>) ຊັ**=350**Ω 20 20 -40 -20 4 10 12 14 16 0 20 40 60 80 100 6 8 Forward Current, I<sub>e</sub> (mA) Temperature, T<sub>A</sub> (°C) Figure 10. Rise and Fall Time vs. Temperature Figure 9. Pulse Width Distortion vs. Temperature 80 250 l\_=7.5mA I\_=7.5mA V<sub>cc</sub>=5V 70 V<sub>cc</sub>=5∨ 200 Pulse Width Distortion, PWD (ns) 60 $R_1=4k\Omega(T_r)$ Rise and Fall Time, $T_r / T_r$ (ns) 0 01 051 $R_1=4k\Omega$ 50 40 $R = 4k\Omega$ (T<sub>f</sub>) R<sub>L</sub>=1kΩ | R<sub>L</sub>=350Ω 30 R,=1kΩ(T,) $R_1=350\Omega(T)$ 20 R,=1kΩ 10 R, =350Ω 0 0 -40 .20 0 20 40 60 80 100 20 -40 -20 40 60 80 100 0 Temperature, T<sub>A</sub> (°C) Temperature, T<sub>A</sub> (°C) Figure 11. Enable Propagation Delay vs. Temperature 120 100 Enable Propagation Delay, $T_{_{E}}$ (ns) $R_L = 4k\Omega(T_{ELH})$ 80 R.=4ks 60 (T<sub>BHL</sub>) R\_=1kΩ R =350 $R_1 = 1 k \Omega(T_{EHL})$ R =350Ω(T<sub>FLH</sub>) 40 20 0 -20 20 60 -40 0 40 80 100 Temperature, T<sub>A</sub> (°C)

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#### Fig. 12 Test circuit and waveforms for tPHL, tPLH, tr, and tf

#### Fig. 13 Test circuit and waveform for tEHLand tELH





#### Fig. 14 Test circuit Common mode Transient Immunity



#### Fig. 15 Recommended drive circuit for EL0611 families for high-CMR



#### Notes

- \*3. The VCC supply must be bypassed by a 0.1µF capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to the package VCC and GND pins
- \*4. Enable Input No pull up resistor required as the device has an internal pull up resistor.
- \*5. tPLH Propagation delay is measured from the 3.75mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
- \*6. tPHL Propagation delay is measured from the 3.75mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
- \*7. tr Rise time is measured from the 90% to the 10% levels on the LOW to HIGH transition of the output pulse.
- \*8. tf Fall time is measured from the 10% to the 90% levels on the HIGH to LOW transition of the output pulse.
- \*9. tELH Enable input propagation delay is measured from the 1.5V level on the HIGH to LOW transition of the input voltage pulse to the 1.5V level on the LOW to HIGH transition of the output voltage pulse.
- \*10. tEHL Enable input propagation delay is measured from the 1.5V level on the LOW to HIGH transition of the input voltage pulse to the 1.5V level on the HIGH to LOW transition of the output voltage pulse.
- \*11 CMH– The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the HIGH state (i.e., VOUT > 2.0V).
- \*12 CML– The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the LOW output state (i.e., VOUT < 0.8V).

#### **Order Information**

#### **Part Number**



#### Note

- X = Part no. (X = 00, 01 or 11)
- Z = Tape and reel option (TA, TB or none).
- V = VDE (optional)

Option	Description	Packing quantity
None	Standard	100 units per tube
-V	Standard + VDE	100 units per tube
(TA)	TA tape & reel option	2000 units per reel
(TB)	TB tape & reel option	2000 units per reel
(TA)-V	TA tape & reel option + VDE	2000 units per reel
(TB)-V	TB tape & reel option + VDE	2000 units per reel

Package Dimension (Dimensions in mm)





#### Recommended pad layout for surface mount leadform





#### **Device Marking**



#### Notes

EL	denotes EVERLIGHT
0600	denotes Device Number
Y	denotes 1 digit Year code
WW	denotes 2 digit Week code
V	denotes VDE (optional)

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#### **Tape & Reel Packing Specifications**



#### **Tape dimension**



Dimension No.	A0	A1	В0	D0	D1	E	F
Dimension(mm)	6.2±0.1	4.1±0.1	5.28±0.1	1.5±0.1	1.5±0.3	1.75±0.1	5.5±0.1
Dimension No.	Ро	P1	P2	t	W	K0	K1
Dimension(mm)	4.0±0.1	8.0±0.1	2.0±0.1	0.4±0.1	12.0+0.3/ -0.1	3.7±0.1	0.3±0.1



Reference: IPC/JEDEC J-STD-020D

#### **Precautions for Use**

- 1. Soldering Condition
  - 1.1 (A) Maximum Body Case Temperature Profile for evaluation of Reflow Profile



Note:

#### Preheat

Temperature min (T <sub>smin</sub> )	150 °C
Temperature max (T <sub>smax</sub> )	200°C
Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )	60-120 seconds
Average ramp-up rate $(T_{smax} \text{ to } T_p)$	3 °C/second max
Other	
Liquidus Temperature (T <sub>L</sub> )	217 °C
Time above Liquidus Temperature (t $_{L}$ )	60-100 sec
Peak Temperature (T <sub>P</sub> )	260°C
Time within 5 °C of Actual Peak Temperature: $T_P$ - 5°C	30 s
Ramp- Down Rate from Peak Temperature	6°C /second max.
Time 25°C to peak temperature	8 minutes max.
Reflow times	3 times

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